Se	Search Notes				

Applicati n No.	Applicant(s)	
10/066,187	TEIG ET AL.	
Examiner	Art Unit	
Binh C. Tat	2825	

SEARCHED			
Class	Subclass	Date	Examiner
716	1-14 and 16-18	6/10/2004	вт
703	13-17	6/10/2004	ВТ
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
716	1-14	6/10/2004	ВТ
716	16-18	6/10/2004	вт
703	13-17	6/10/2004	ВТ

SEAR (INCLUDING S	RCH NOTES EARCH STRATEGY	′)
	DATE	EXMR
EAST SEARCH	6/10/2004	вт
IEEE	6/10/2004	вт